

## **FDFS2P103**

## Integrated P-Channel PowerTrench® MOSFET and Schottky Diode

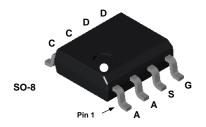
### **General Description**

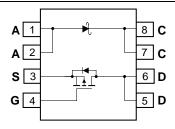
The FDFS2P103 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low onstate resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

#### **Features**

- -5.3 A, -30V  $R_{DS(ON)} = 59 \text{ m}\Omega$  @  $V_{GS} = -10 \text{ V}$  $R_{DS(ON)} = 92 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$
- V<sub>F</sub> < 0.52 V @ 1 A (T<sub>J</sub> = 125°C)
   V<sub>F</sub> < 0.57 V @ 1 A (T<sub>J</sub> = 25°C)
- Schottky and MOSFET incorporated into single power surface mount SO-8 package
- Electrically independent Schottky and MOSFET pinout for design flexibility





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	MOSFET Drain-Source Voltage		-30	V
V <sub>GSS</sub>	MOSFET Gate-Source Voltage		±25	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	-5.3	А
	- Pulsed		-20	
$P_D$	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	
		(Note 1b)	1	
		(Note 1c)	0.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperation	ture Range	−55 to +150	°C
$V_{RRM}$	Schottky Repetitive Peak Reverse Voltage	Э	30	V
Io	Schottky Average Forward Current	(Note 1a)	1	А

**Package Marking and Ordering Information** 

Device Marking	Device Marking Device		Tape width	Quantity	
FDFS2P103	FDFS2P103	13"	12mm	2500 units	

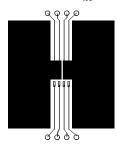
		Min	Тур	Max	Units		
Off Char	racteristics				I	l	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$ ,	$I_D = -250  \mu A$	-30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250  \mu A, Re$	eferenced to 25°C		-23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V},$	V <sub>GS</sub> = 0 V			-1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 25 \text{ V},$	$V_{DS} = 0 V$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -25 \text{ V},$	$V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)				•		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = -250  \mu A$	-1	-1.7	-3	V
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate Threshold Voltage Temperature Coefficient		eferenced to 25°C		4.5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = -10 \text{ V},$ $V_{GS} = -4.5 \text{ V},$ $V_{GS} = -10 \text{ V}, I_D = -10 \text{ V},$			46 70 63	59 92 88	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V},$	V <sub>DS</sub> = -5 V	-20			Α
g <sub>FS</sub>	Forward Transconductance		$I_D = -5.3 \text{ A}$		10		S
Dvnamic	Characteristics	1			I	I	
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V},$		528		pF	
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		132		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			70		pF	
Switchin	ng Characteristics (Note 2)	•					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V},$	$I_D = -1 A$ ,		7	14	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -10 \text{ V},$	$R_{GEN} = 6 \Omega$		13	24	ns
t <sub>d(off)</sub>	Turn-Off Delay Time				14	25	ns
t <sub>f</sub>	Turn-Off Fall Time				9	17	ns
Qg	Total Gate Charge	$V_{DS} = -15 \text{ V},$	$I_D = -5.3 \text{ A},$		5.3	8	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -5 \text{ V}$			2.2		nC
$Q_{gd}$	Gate-Drain Charge				1.6		nC
Drain-Se	ource Diode Characteristics	and Maximum	Ratings				
Is	Maximum Continuous Drain-Source					-1.3	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S =$	= -1.3 A (Note 2)		-0.7	-1.2	V
Schottky	y Diode Characteristics						-
I <sub>R</sub>	Reverse Leakage	V <sub>R</sub> = 30 V	$T_J = 25^{\circ}C$		15	100	μΑ
	Í	1	T <sub>J</sub> = 125°C		6	30	mΑ
V <sub>F</sub>	Forward Voltage	I <sub>E</sub> = 1A	T <sub>J</sub> = 25°C		0.41	0.57	V

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	135	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

#### Notes

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz copper



135°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

**2.** Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%

## **Typical Characteristics**

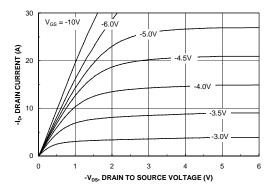


Figure 1. On-Region Characteristics.

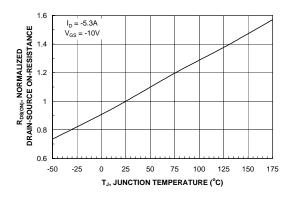


Figure 3. On-Resistance Variation with Temperature.

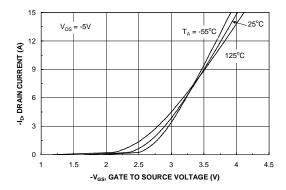


Figure 5. Transfer Characteristics.

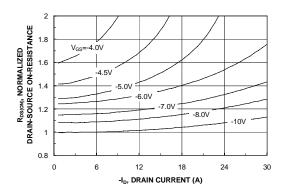


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

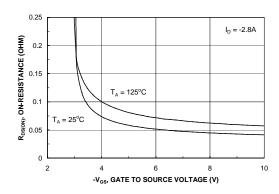


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

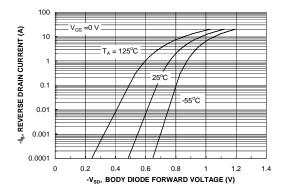
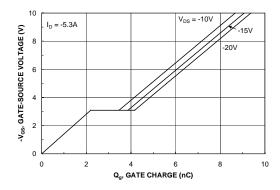


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



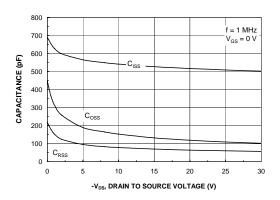


Figure 7. Gate Charge Characteristics.

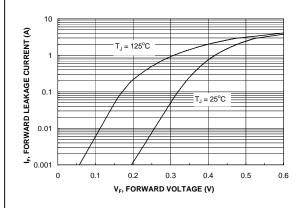


Figure 8. Capacitance Characteristics.

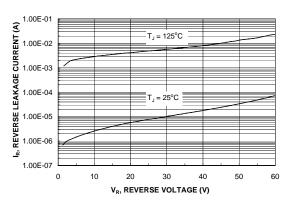


Figure 9. Schottky Diode Forward Voltage.



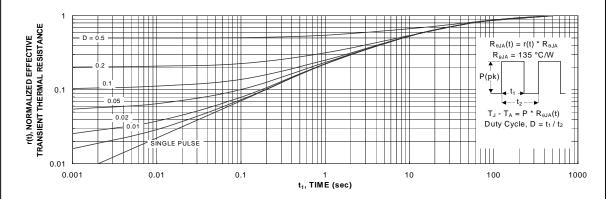
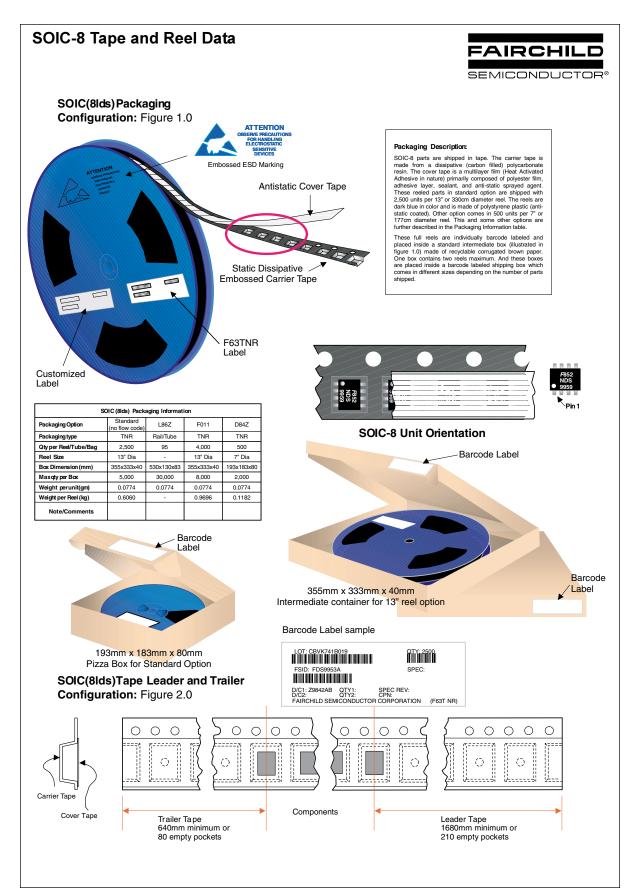


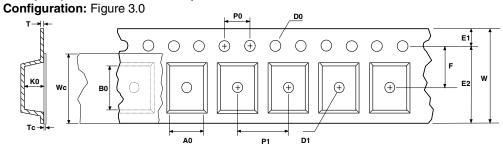
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.





### SOIC(8lds) Embossed Carrier Tape



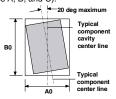


	Dimensions are in millimeter													
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	КО	т	Wc	Тс
SOIC(8lds) (12mm)	5.30 +/-0.10	6.50 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



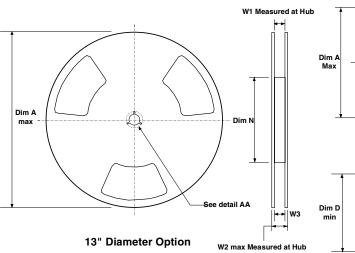
Sketch B (Top View)
Component Rotation

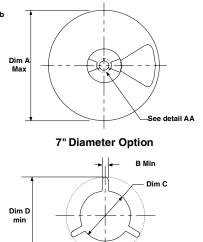


Sketch C (Top View)

Component lateral movement

### SOIC(8lds) Reel Configuration: Figure 4.0



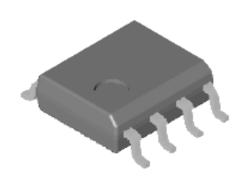


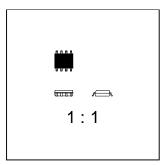
								DETAIL AA	1
	Dimensions are in inches and millimeters								
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	2.165 55	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4

### **SOIC-8 Package Dimensions**



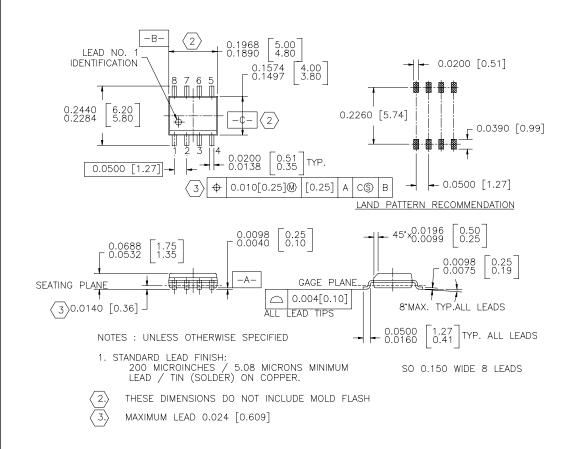
# SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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